



FCC PART 15 B
TEST REPORT

For

Hanwang Technology Co., Ltd

Hanvon Tower, Building No.5, Zhongguancun Software Park, Haidian District, Beijing, China

FCC ID: XQI-FACEID-FX10

Report Type: Original Report	Product Type: Facial Recognition Terminal
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Report Number: <u>RBJ150615050-00B</u>	
Report Date: <u>2015-07-27</u>	
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TABLE OF CONTENTS

GENERAL INFORMATION	3
PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST (EUT)	3
OBJECTIVE	3
RELATED SUBMITTAL(S)/GRANT(S).....	3
TEST METHODOLOGY	3
TEST FACILITY	3
SYSTEM TEST CONFIGURATION	4
DESCRIPTION OF TEST CONFIGURATION	4
EQUIPMENT MODIFICATIONS	4
LOCAL SUPPORT EQUIPMENT LIST AND DETAILS	4
SUPPORT CABLE LIST AND DETAILS	4
CONFIGURATION OF TEST SETUP	5
SUMMARY OF TEST RESULTS	6
FCC§15.107 - CONDUCTED EMISSIONS	7
MEASUREMENT UNCERTAINTY	7
EUT SETUP	7
EMI TEST RECEIVER SETUP.....	8
TEST EQUIPMENT LIST AND DETAILS.....	8
TEST PROCEDURE	8
CORRECTED AMPLITUDE & MARGIN CALCULATION	8
TEST RESULTS SUMMARY	9
TEST DATA	9
FCC §15.109 - RADIATED SPURIOUS EMISSIONS	12
MEASUREMENT UNCERTAINTY	12
EUT SETUP	12
EMI TEST RECEIVER SETUP.....	13
TEST PROCEDURE	13
TEST EQUIPMENT LIST AND DETAILS.....	14
CORRECTED AMPLITUDE & MARGIN CALCULATION	14
TEST RESULTS SUMMARY	14
TEST DATA	14
DECLARATION LETTER	19

GENERAL INFORMATION

Product Description for Equipment Under Test (EUT)

The *Hanwang Technology Co., Ltd*'s product, model number: *F910 (FCC ID: XQI-FACEID-FX10)* (the "EUT") in this report was a *Facial Recognition Terminal*, which was measured approximately: 21.5cm (L) x9.5m (W) x 15.0 cm (H), rated input voltage: DC12V from adapter.

Note: The series product, model F910,F910S, F910X, F710, F710S, F710X, F810, F810S, F810X are electrically identical, the difference between them is just the model name, we selected F910 for fully testing, the details was explained in the attached declaration letter.

All measurement and test data in this report was gathered from production sample serial number: 150615050(Assigned by Applicant). The EUT was received on 2015-06-09.

Objective

This test report is prepared on behalf of *Hanwang Technology Co., Ltd* in accordance with Part 2, Subpart J, and Part 15-Subparts A and B of the Federal Communications Commission's rules.

The objective of the manufacturer is to determine the compliance of EUT with FCC Part 15 B Class B.

Related Submittal(s)/Grant(s)

FCC Part 15C DXX submissions with FCC ID: XQI-FACEID-FX10.

Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2009, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

All radiated and conducted emissions measurement was performed at Bay Area Compliance Laboratories Corp. (Dongguan).

Test Facility

The Test site used by Bay Area Compliance Laboratories Corp. (Dongguan) to collect test data is located on the No.69 Pulongcun, Puxinhu Industrial Zone, Tangxia, Dongguan, Guangdong, China

Test site at Bay Area Compliance Laboratories Corp. (Dongguan) has been fully described in reports submitted to the Federal Communications Commission (FCC). The details of these reports have been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 06, 2015. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2009.

The Federal Communications Commission has the reports on file and is listed under FCC Registration No.: 273710. The test site has been approved by the FCC for public use and is listed in the FCC Public Access Link (PAL) database.

SYSTEM TEST CONFIGURATION

Description of Test Configuration

The system was configured for testing in a typical fashion (as normally used by a typical user).

Equipment Modifications

No modification was made to the EUT tested.

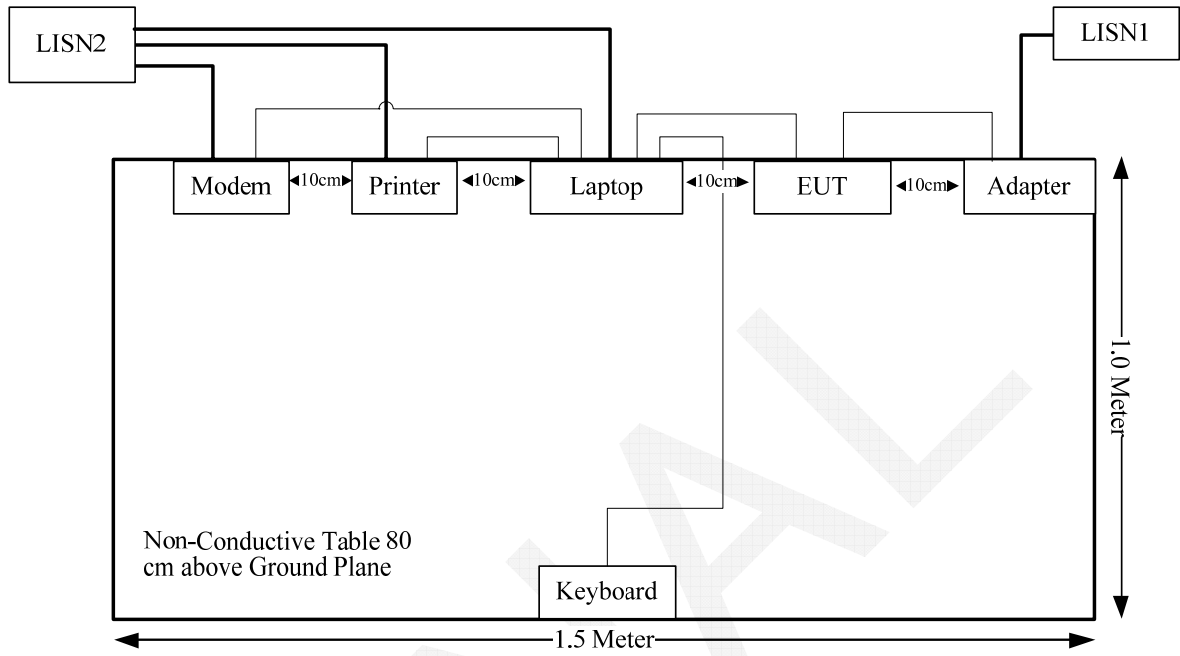
Local Support Equipment List and Details

Manufacturer	Description	Model	Serial Number
DELL	Laptop	PP11L	QDS-BRCM1017
HP	Printer	C3941A	JPTVOB2337
DELL	Keyboard	L100	CNORH656658907BL05DC
SAST	Modem	AEM-2100	0293
Kingston	USB disk	8 GB	/

Support Cable List and Details

Cable Description	Shielding Type	Ferrite Core	Length (m)	From	To
Serial Cable	Yes	No	1.2	Serial Port of Laptop	Modem
Parallel Cable	Yes	No	1.2	Parallel Port of Laptop	Printer
Keyboard Cable	Yes	Yes	1.8	USB Port of Laptop	Keyboard
RJ45 Cable	No	No	1.0	Network Port of EUT	Laptop

Configuration of Test Setup



SUMMARY OF TEST RESULTS

FCC Rules	Description of Test	Results
§15.107	Conducted Emissions	Compliance
§15.109	Radiated Emissions	Compliance

FINAL

FCC§15.107 - CONDUCTED EMISSIONS

Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are Receiver, cable loss, and LISN.

Compliance or non-compliance with a disturbance limit shall be determined in the following manner:

If U_{lab} is less than or equal to U_{cispr} of Table 1, then:

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

If U_{lab} is greater than U_{cispr} of Table 1, then:

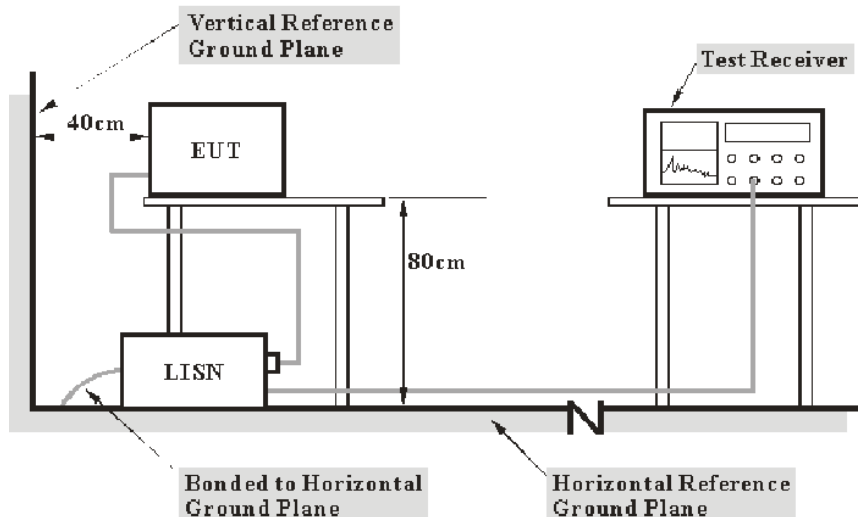
- compliance is deemed to occur if no measured disturbance level, increased by $(U_{lab} - U_{cispr})$, exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level, increased by $(U_{lab} - U_{cispr})$, exceeds the disturbance limit.

Based on CISPR 16-4-2: 2011, measurement uncertainty of conducted disturbance at mains port using AMN at Bay Area Compliance Laboratories Corp. (Dongguan) is 3.46 dB (150 kHz to 30 MHz).

Table 1 – Values of U_{cispr}

Measurement	U_{cispr}
Conducted disturbance at mains port using AMN (150 kHz to 30 MHz)	3.4 dB

EUT Setup



- Note: 1. Support units were connected to second LISN.
 2. Both of LISNs (AMN) 80 cm from EUT and at the least 80 cm from other units and other metal planes support units.

The setup of EUT is according with per ANSI C63.4-2009 measurement procedure. The specification used was with the FCC Part 15 B Class B limits.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The adapter was connected to a 120V/60Hz AC power source.

EMI Test Receiver Setup

The EMI test receiver was set to investigate the spectrum from 150 kHz to 30 MHz.

During the conducted emission test, the EMI test receiver was set with the following configurations:

Frequency Range	IF B/W
150 kHz – 30 MHz	9 kHz

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	EMI Test Receiver	ESCS 30	830245/006	2014-10-20	2015-10-20
R&S	L.I.S.N	ESH2-Z5	892107/021	2015-06-09	2016-06-09
R&S	Two-line V-network	ENV 216	3560.6550.12	2014-12-11	2015-12-11
R&S	Test Software	EMC32	Version8.53.0	N/A	N/A

* Statement of Traceability: Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

Test Procedure

During the conducted emission test, the adapter was connected to the outlet of the first LISN and the other support equipments were connected to the outlet of the second LISN.

Maximizing procedure was performed on the six (6) highest emissions of the EUT.

All data was recorded in the Quasi-peak and average detection mode.

Corrected Amplitude & Margin Calculation

The basic equation is as follows:

$$V_C = V_R + A_C + VDF$$

Herein,

V_C : corrected voltage amplitude

V_R : reading voltage amplitude

A_C : attenuation caused by cable loss

VDF: voltage division factor of AMN or ISN

The “**Margin**” column of the following data tables indicates the degree of compliance within the applicable limit. For example, a margin of 7dB means the emission is 7dB below the maximum limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

Test Results Summary

According to the recorded data in following table, the EUT complied with the FCC Part 15 B Class B, with the worst margin reading of:

4.70 dB at 0.563041 MHz in the Line conducted mode

Test Data

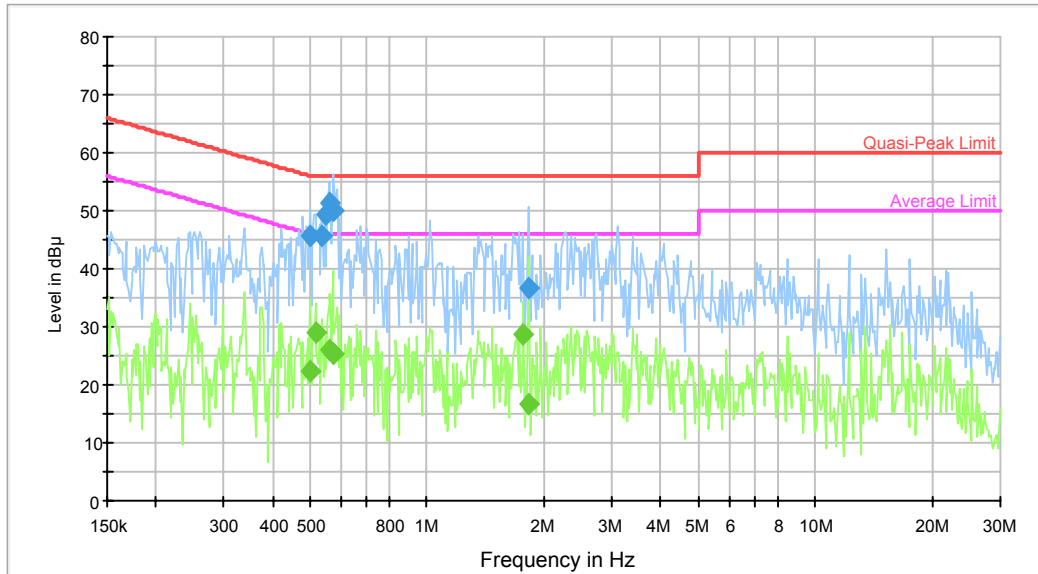
Environmental Conditions

Temperature:	27.1 °C
Relative Humidity:	61 %
ATM Pressure:	99.9 kPa

The testing was performed by Lion Xiao on 2015-06-24.

Test Mode: Operating (Facial recognition+Record+Communication)

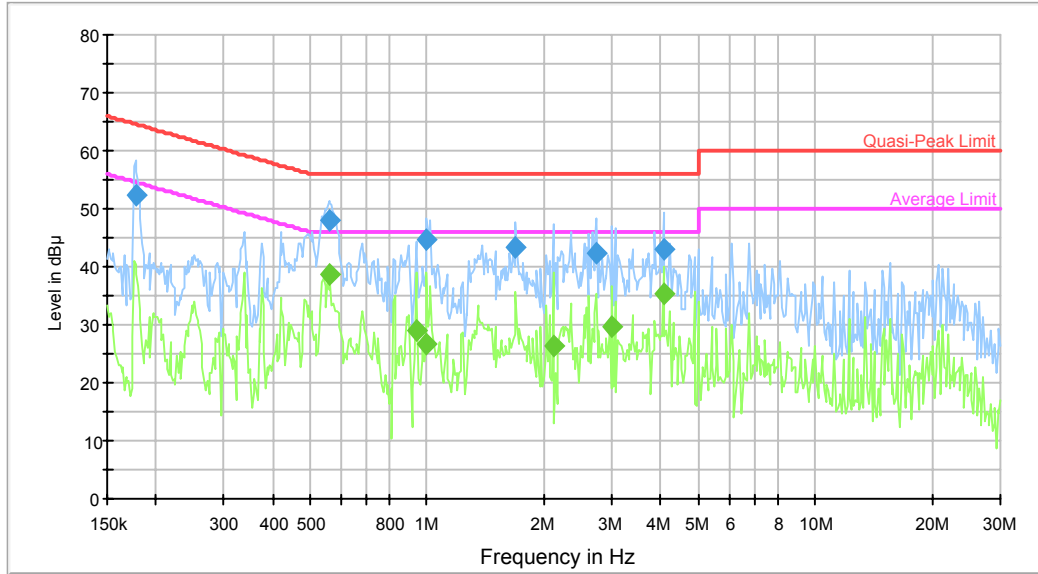
AC120V, 60Hz, Line:



Frequency (MHz)	QuasiPeak (dBµV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)	Comment
0.499611	45.7	9.000	L1	10.1	10.3	56.0	Compliance
0.536756	45.8	9.000	L1	10.1	10.2	56.0	Compliance
0.545378	49.5	9.000	L1	10.1	6.5	56.0	Compliance
0.563041	51.3	9.000	L1	10.1	4.7	56.0	Compliance
0.572086	50.0	9.000	L1	10.2	6.0	56.0	Compliance
1.831043	36.6	9.000	L1	10.4	19.4	56.0	Compliance

Frequency (MHz)	Average (dBµV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)	Comment
0.499611	22.4	9.000	L1	10.1	23.6	46.0	Compliance
0.515791	29.0	9.000	L1	10.1	17.0	46.0	Compliance
0.563041	26.0	9.000	L1	10.1	20.0	46.0	Compliance
0.572086	25.4	9.000	L1	10.2	20.6	46.0	Compliance
1.773603	28.6	9.000	L1	10.4	17.4	46.0	Compliance
1.831043	16.6	9.000	L1	10.4	29.4	46.0	Compliance

AC120V, 60Hz, Neutral:



Frequency (MHz)	QuasiPeak (dBμV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBμV)	Comment
0.177322	52.4	9.000	N	10.2	12.2	64.6	Compliance
0.558572	48.1	9.000	N	10.1	7.9	56.0	Compliance
0.999305	44.8	9.000	N	10.4	11.2	56.0	Compliance
1.690804	43.5	9.000	N	10.4	12.5	56.0	Compliance
2.727252	42.4	9.000	N	10.5	13.6	56.0	Compliance
4.062112	42.9	9.000	N	10.7	13.1	56.0	Compliance

Frequency (MHz)	Average (dBμV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBμV)	Comment
0.563041	38.7	9.000	N	10.1	7.3	46.0	Compliance
0.937592	29.0	9.000	N	10.4	17.0	46.0	Compliance
0.999305	26.5	9.000	N	10.4	19.5	46.0	Compliance
2.113432	26.5	9.000	N	10.4	19.5	46.0	Compliance
3.000901	29.8	9.000	N	10.6	16.2	46.0	Compliance
4.062112	35.2	9.000	N	10.7	10.8	46.0	Compliance

FCC §15.109 - RADIATED SPURIOUS EMISSIONS

Measurement Uncertainty

Compliance or non-compliance with a disturbance limit shall be determined in the following manner:

If U_{lab} is less than or equal to U_{cispr} of Table 1, then:

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

If U_{lab} is greater than U_{cispr} of Table 1, then:

- compliance is deemed to occur if no measured disturbance level, increased by $(U_{lab} - U_{cispr})$, exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level, increased by $(U_{lab} - U_{cispr})$, exceeds the disturbance limit.

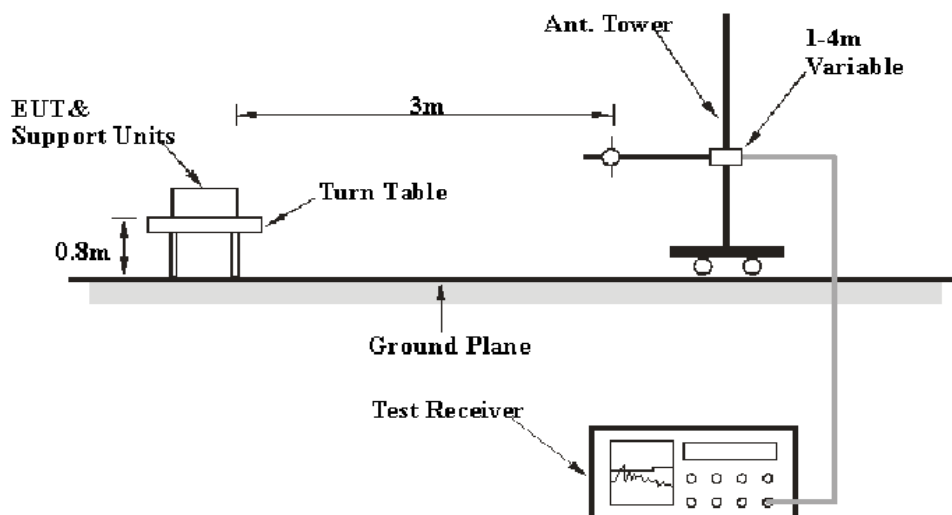
Based on CISPR 16-4-2: 2011, measurement uncertainty of radiated emission at a distance of 3m at Bay Area Compliance Laboratories Corp. (Dongguan) is: 30M~200MHz: 5.0 dB; 200M~1GHz: 6.2 dB; 1G~6GHz: 4.45 dB, 6G~18GHz: 5.23 dB

Table 1 – Values of U_{cispr}

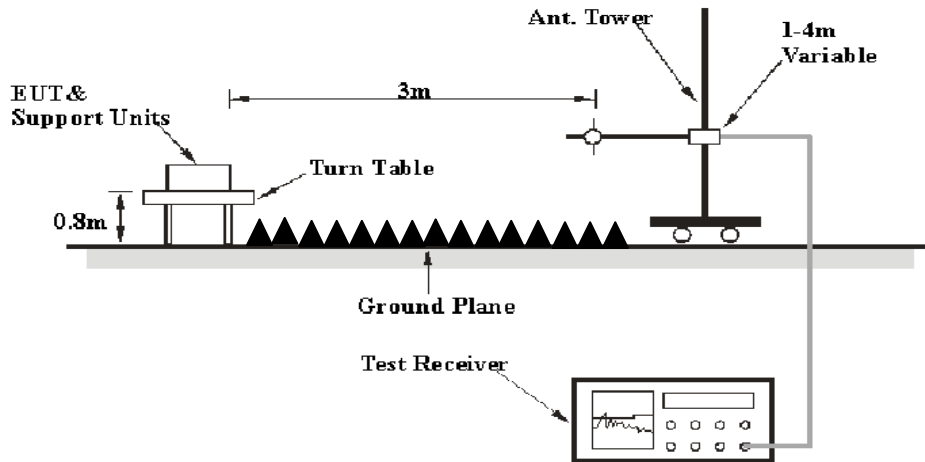
Measurement		U_{cispr}
Radiated disturbance (electric field strength at an OATS or in a SAC)	(30 MHz to 1000 MHz)	6.3 dB
Radiated disturbance (electric field strength in a FAR)	(1 GHz to 6 GHz)	5.2 dB
Radiated disturbance (electric field strength in a FAR)	(6 GHz to 18 GHz)	5.5 dB

EUT Setup

Below 1GHz:



Above 1GHz:



The radiated emission tests were performed in the 3 meters chamber test site, using the setup accordance with the ANSI C63.4-2009. The specification used was the FCC Part 15.109 Class B limits.

EMI Test Receiver Setup

The system was investigated from 30 MHz to 6 GHz.

During the radiated emission test, the EMI test receiver was set with the following configurations:

Frequency Range	RBW	Video B/W	IF B/W	Detector
30 MHz – 1000 MHz	120 kHz	300 kHz	120 kHz	QP
Above 1 GHz	1 MHz	3 MHz	/	Peak
	1 MHz	10 Hz	/	Ave.

Test Procedure

Maximizing procedure was performed on the highest emissions to ensure that the EUT complied with all installation combinations.

The data was recorded in the Quasi-peak detection mode for below 1 GHz, peak and average detection mode above 1 GHz.

Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	EMI Test Receiver	ESCI	100224	2015-05-09	2016-05-09
Sunol Sciences	Antenna	JB3	A060611-3	2014-07-28	2017-07-27
HP	Amplifier	8447E	2434A02181	2014-09-01	2015-09-01
Agilent	Spectrum Analyzer	E4440A	SG43360054	2014-12-04	2015-12-04
ETS-Lindgren	Horn Antenna	3115	000 527 35	2012-09-06	2015-09-06
Mini-Circuit	Amplifier	ZVA-213-S+	054201245	2015-02-19	2016-02-19

* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Loss and Cable Loss, and subtracting the Amplifier Gain from the Meter Reading. The basic equation is as follows:

$$\text{Corrected Amplitude} = \text{Meter Reading} + \text{Antenna Loss} + \text{Cable Loss} - \text{Amplifier Gain}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7 dB means the emission is 7 dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

Test Results Summary

According to the data in the following table, the EUT complied with the FCC Part 15 B Class B, with the worst margin reading of:

2.30 dB at 199.7500 MHz in the Vertical polarization

Test Data

Environmental Conditions

Temperature:	26.1°C
Relative Humidity:	53 %
ATM Pressure:	99.2 kPa

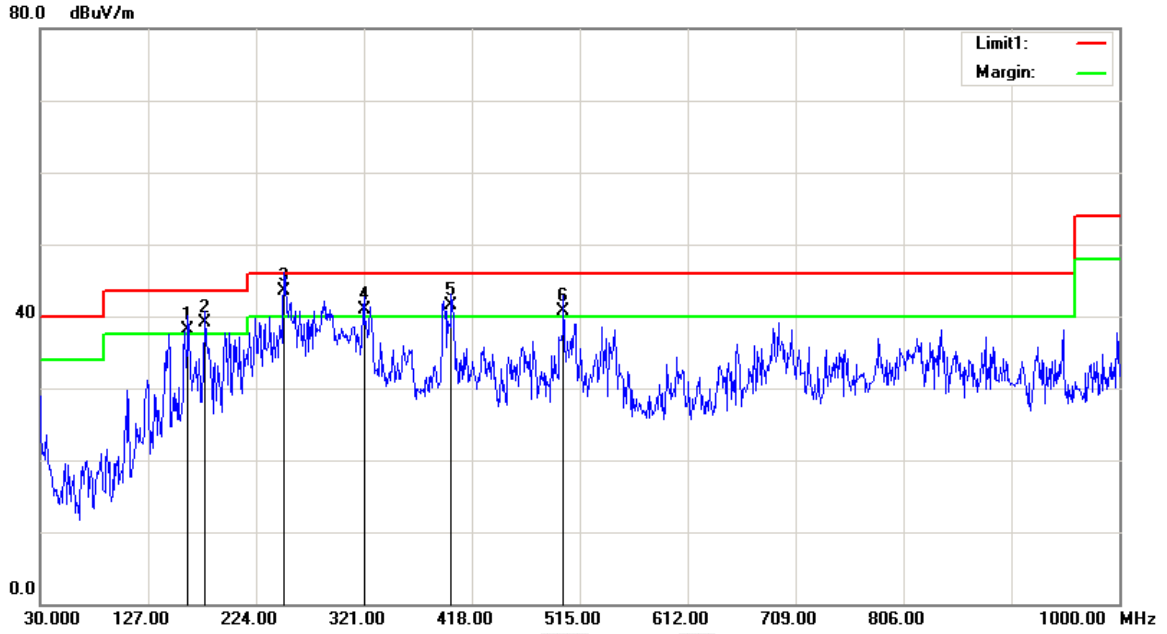
The testing was performed by Lion Xiao from 2015-06-29

Test Result: Compliance

Test Mode: Operating (Facial recognition+Record+Communication)

1) Below 1GHz:

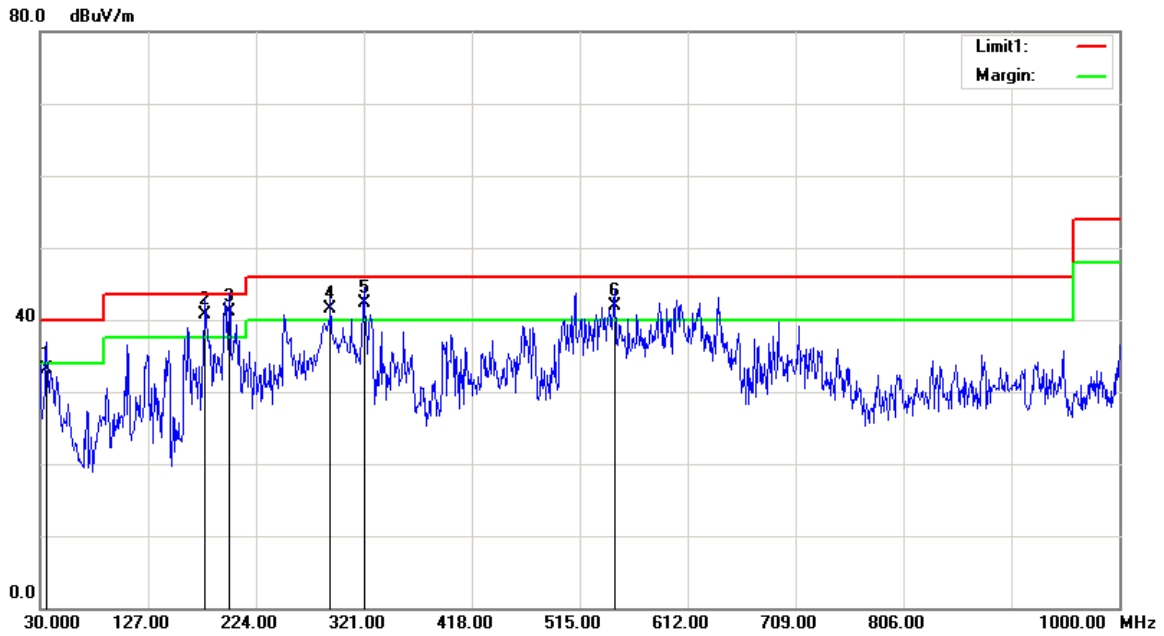
Horizontal



Frequency (MHz)	Receiver Reading (dBµV)	Detector (PK/QP/Ave)	Correction Factor (dB/m)	Cord. Amp. (dBµV/m)	Limit (dBµV/m)	Margin (dB)
162.8900	45.74	QP	-7.54	38.20	43.50	5.30
178.4100	47.66	QP	-8.56	39.10	43.50	4.40*
249.2200	51.64	QP	-8.04	43.60	46.00	2.40*
321.0000	46.47	QP	-5.57	40.90	46.00	5.10*
399.5700	45.21	QP	-3.71	41.50	46.00	4.50*
500.4500	42.40	QP	-1.70	40.70	46.00	5.30*

*Within measurement uncertainty!

Vertical

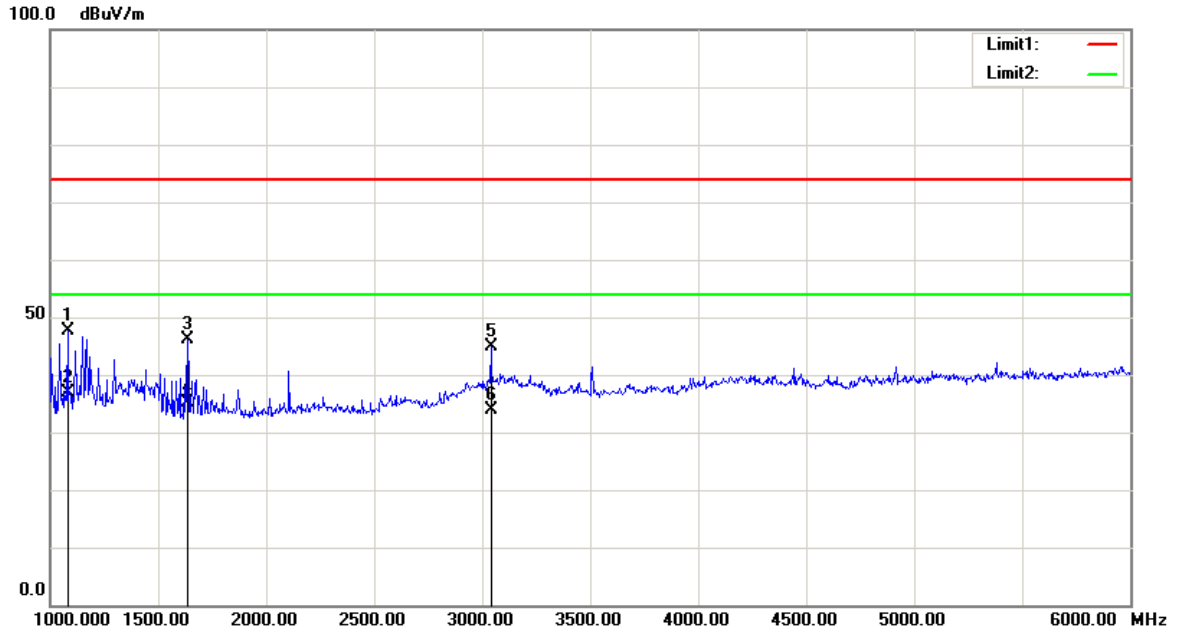


Frequency (MHz)	Receiver Reading (dBµV)	Detector (PK/QP/Ave)	Correction Factor (dB/m)	Cord. Amp. (dBµV/m)	Limit (dBµV/m)	Margin (dB)
35.8200	36.47	QP	-3.37	33.10	40.00	6.90
178.4100	49.26	QP	-8.56	40.70	43.50	2.80*
199.7500	48.79	QP	-7.59	41.20	43.50	2.30*
290.9300	47.64	QP	-6.14	41.50	46.00	4.50*
321.0000	47.87	QP	-5.57	42.30	46.00	3.70*
546.0400	43.00	QP	-1.00	42.00	46.00	4.00*

**Within measurement uncertainty!*

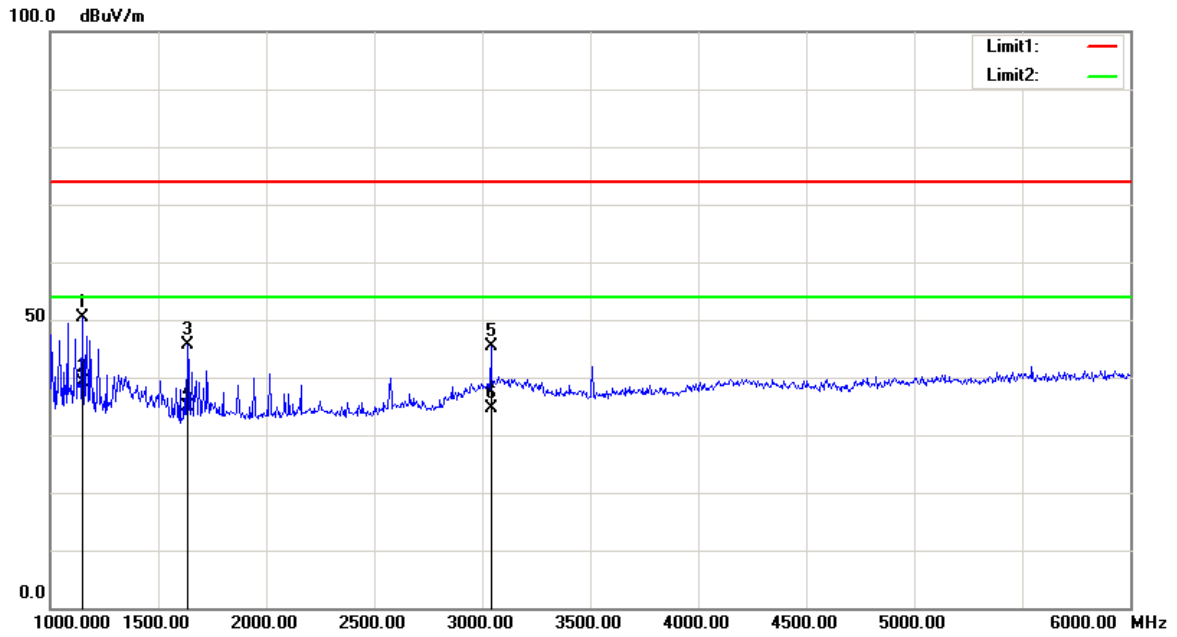
2) Above 1GHz:

Horizontal



Frequency (MHz)	Receiver Reading (dBμV)	Detector (PK/QP/Ave)	Correction Factor (dB/m)	Cord. Amp. (dBμV/m)	Limit (dBμV/m)	Margin (dB)
1080.000	48.66	peak	-1.14	47.52	74.00	26.48
1080.000	38.01	AVG	-1.14	36.87	54.00	17.13
1637.500	47.25	peak	-1.06	46.19	74.00	27.81
1637.500	36.29	AVG	-1.06	35.23	54.00	18.77
3042.500	38.45	peak	6.50	44.95	74.00	29.05
3042.500	27.28	AVG	6.50	33.78	54.00	20.22

Vertical



Frequency (MHz)	Receiver Reading (dBµV)	Detector (PK/QP/Ave)	Correction Factor (dB/m)	Cord. Amp. (dBµV/m)	Limit (dBµV/m)	Margin (dB)
1152.500	51.22	peak	-0.96	50.26	74.00	23.74
1152.500	40.13	AVG	-0.96	39.17	54.00	14.83
1637.500	46.68	peak	-1.06	45.62	74.00	28.38
1637.500	35.95	AVG	-1.06	34.89	54.00	19.11
3042.500	38.90	peak	6.50	45.40	74.00	28.60
3042.500	28.11	AVG	6.50	34.61	54.00	19.39

DECLARATION LETTER



Hanwang Technology Co., Ltd
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Beijing, china
Tel: +86 (0)10 8278 6760
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DECLARATION OF SIMILARITY

Date: 2015-7-1

Dear Sir or Madam:

We, Hanwang Technology Co., Ltd, Hereby declare that product: Facial Recognition Terminal, model(s): F910, F910S, F910X, F710, F710S, F710X, F810, F810S, F810X, are electrically identical with the same electromagnetic emissions and electromagnetic compatibility characteristics. with the model F910 that were tested by BACL, the results of which are featured in BACL projects.

Their differences as the following:

The models: F910, F910S, F910X, F710, F710S, F710X, F810, F810S, F810X, share same PCB layout and schematic, they just have different model name. Please contact me should there be need for any additional clarification or information.

Best Regards,

Signature: *Shen Yuan*

Printed Name: Shen Yuan

Title: QA Manager

*****END OF REPORT*****